FORMPTO-1449

## US DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE

APPLICANT: MARTIN RICHARDSON

FOR:

EUV, XUV, AND X-RAY WAVELENGTH SOURCES CREATED FROM LASER PLASMA

PRODUCED FROM LIQUID METAL SOLUTIONS

## LIST OF ART CITED BY APPLICANT

## **U.S. PATENT DOCUMENTS**

	EXAMINER	DOCUMENT NO.	DATE	NAME	CLASS	SUBCLASS	FILING DATE
CT	AA	4.024,400	05/17/77	Blytas et al.	250	432	05/13/76
1	AB	4,328,464	05/04/82	Pivirotto	330	4.3	02/07/80
	AC	4,700,371	10/13/87	Forsyth et al.	378	34	11/08/84
	AD	4,723,262	02/02/88	Noda et al.	378	119	12/26/85
	AE	4,866,517	09/12/89	Mochizuke et al.	378	119	09/10/87
	AF	4,953,191	08/28/90	Smither et al.	. 378	143	07/24/89
	AG	5,126,755	06/30/92	Sharpe et al.	346	75	03/26/91
	АН	5,142,297	08/25/92	Eijkman et al.	346	1.1	03/26/90
	AJ	5,148,462	09/15/92	Spitsyn et al.	378	143	04/08/91
	AJ	5,151,928	09/29/92	Hirose	378	119	08/20/91
	AK	5,243,638	09/07/93	Wang et al.	378	119	03/10/92
	AL	5,257,303	10/26/93	Das Gupta	378	85	08/03/92
	AM	5,459,771	10/17/95	Richardson et al.	378	119	04/01/94
	AN	5,577,091	11/19/96	Richardson et al	378	119	01/13/95
Ì	AO	5,577,092	11/19/96	Kublak et al.	378	119	11/19/96
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FB Jp JA0267895

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Iwamatsu

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